Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/632,923	NOZU, TAKASHI	
Examiner	Art Unit	
Wonneng Chen	2624	

SEARCHED				
Class	Subclass	Date	Examiner	
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR, FPRS) - See search history printout.	10/30/66	un
IEEE Xplore - See search condition and result printout.	11/1/06.	mi
EAST (updated)	5/14/07	any
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